

**Search Notes**

Application/Control No.

10/806,938

Examiner

Hai L. Nguyen

Applicant(s)/Patent under  
Reexamination

OM ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	141-145, 105,107	6/8/2005	HLN
	113,114		
	291-294		
	298,407		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	6/9/2005	HLN